

Search Notes

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Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

SCHMIDT, JUERGEN

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	2, 3, 7, 12, 39, 40	1/7/2008	HLN
327	42, 43	1/8/2008	HLN
327	47 - 49	1/8/2008	HLN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search see search history printout	1/8/2008	HLN